## Notice of References Cited Application/Control No. O9/738,794 Examiner Douglas Q. Tran Applicant(s)/Patent Under Reexamination HAINES ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,522,421 B2	02-2003	Chapman et al.	358/1.15
	В	US-6,735,641 B1	05-2004	Kobayashi et al.	710/15
	С	US-6,758,316 B2	07-2004	Molbak, Jens H.	194/200
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
· ·	М	US-			-

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
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	R					
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	Т					

## **NON-PATENT DOCUMENTS**

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.